# imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



# Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





#### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	Ι <sub>D</sub> T <sub>A</sub> = +25°C	
60V	$66m\Omega @ V_{GS} = 10V$	4.4A	
	$97m\Omega @ V_{GS} = 4.5V$	3.6A	

#### **Description and Applications**

This MOSFET is designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor Control
- Backlighting
- DC-DC Converters
- Power Management Functions

#### **Features and Benefits**

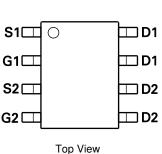
- Low on-resistance
- Fast switching speed
- 100% Unclamped Inductive Switch (UIS) test in production
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

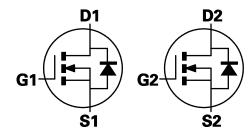
#### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram Below
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 🔞
- Weight: 0.074 grams (Approximate)



Top View





Equivalent Circuit

#### Ordering Information (Notes 4 & 5)

Part Number	Compliance	Case	Packaging
DMN6066SSD-13	Commercial	SO-8	2,500/Tape & Reel
DMN6066SSDQ-13	Automotive	SO-8	2,500/Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

 See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. Automotive products are AEC-Q101 qualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to http://www. diodes.com/quality/product\_grade\_definitions/.

5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

#### **Marking Information**

SO-8



⇒ Manufacturer's Marking
N6066SD = Product Type Marking Code
YYWW = Date Code Marking
YY = Year (ex: 09 = 2009)
WW = Week (01 - 53)



#### Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V <sub>DSS</sub>	60	V
Gate-Source Voltage		(Note 6)	V <sub>GS</sub>	±20	V
Single Pulsed Avalanche En	ergy	(Note 13)	E <sub>AS</sub>	37.5	mJ
Single Pulsed Avalanche Cu	rrent	(Note 13)	I <sub>AS</sub>	5.0	А
Continuous Drain Current V <sub>GS</sub> = 10V	(Note 8)		4.4		
	$V_{GS} = 10V$	$T_A = +70^{\circ}C$ (Note 8)	ID	3.5	А
	(Note 7)		3.3		
Pulsed Drain Current	$V_{GS} = 10V$	(Note 9)	I <sub>DM</sub>	17.0	А
Continuous Source Current	(Body diode)	(Note 8)	ls	3.2	А
Pulsed Source Current (Bod	y diode)	(Note 9)	I <sub>SM</sub>	17.0	А

#### Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

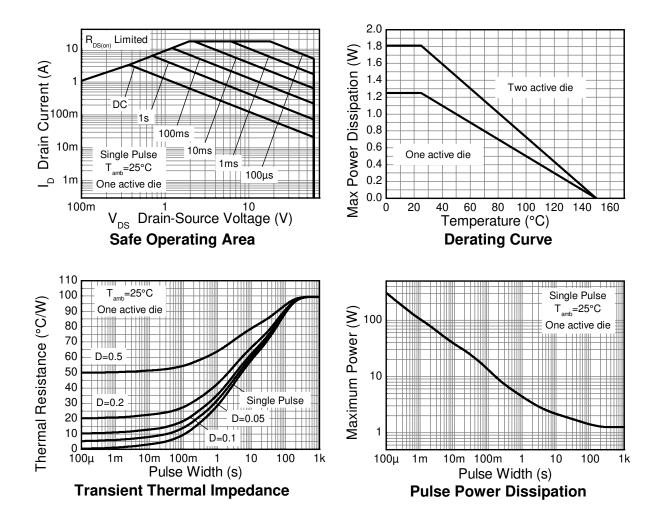
Characteristic		Symbol	Value	Unit	
	(Notes 7 & 10)		1.25 10		
Power Dissipation Linear Derating Factor	(Notes 7 & 11)	PD	1.8 14.3	W mW/°C	
	(Notes 8 & 10)		2.14 17.2		
Thermal Resistance, Junction to Ambient	(Notes 7 & 10)		100	°C/W	
	(Notes 7 & 11)	R <sub>0</sub> JA	70		
	(Notes 8 & 10)		58		
Thermal Resistance, Junction to Lead	(Notes 10 & 12)	R <sub>0JL</sub>	55		
Operating and Storage Temperature Range		TJ, TSTG	-55 to 150	°C	

Notes: 6. AEC-Q101  $V_{GS}$  maximum is  $\pm 16V.$ 

7. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
Same as note (3), except the device is measured at t ≤ 10 sec.
Same as note (3), except the device is pulsed with D = 0.02 and pulse width 300µs. The pulse current is limited by the maximum junction temperature.
For a dual device with one active die.
For a device with two active die running at equal power.
Thermal resistance from junction to solder-point (at the end of the drain lead).
UIS in production with L = 3.0mH, I<sub>AS</sub> = 5.0A, R<sub>G</sub> = 25Ω, V<sub>DD</sub> = 50V, starting T<sub>J</sub> = +25°C.



#### **Thermal Characteristics**





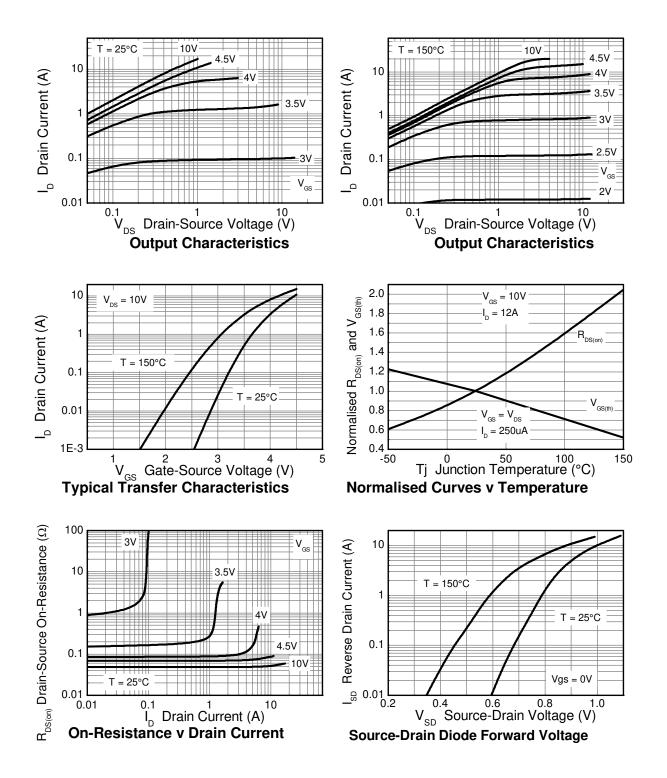
## Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60		_	V	$I_{D} = 250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_		0.5	μA	V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	IGSS			±100	nA	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V	
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.0		3.0	V	$I_{D}$ = 250 $\mu$ A, $V_{DS}$ = $V_{GS}$	
Statia Duain Cauma On Basistense (Nata 14)			0.048	0.066	0	V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.5A	
Static Drain-Source On-Resistance (Note 14)	R <sub>DS (ON)</sub>		0.068	0.097	Ω	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.5A	
Forward Transconductance (Notes 14 & 15)	<b>g</b> fs		19.2	_	S	V <sub>DS</sub> = 15V, I <sub>D</sub> = 6A	
Diode Forward Voltage (Note 14)	V <sub>SD</sub>		0.89	1.15	V	I <sub>S</sub> = 4.5A, V <sub>GS</sub> = 0V	
Reverse recovery time (Note 15)	t <sub>rr</sub>		22.2	_	ns	-I <sub>S</sub> = 1.9A, di/dt= 100A/μs	
Reverse recovery charge (Note 15)	Q <sub>rr</sub>		16.9	_	nC		
DYNAMIC CHARACTERISTICS (Note 15)							
Input Capacitance	Ciss		502	_	pF	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V f= 1MHz	
Output Capacitance	Coss	_	45.7	_	pF		
Reverse Transfer Capacitance	Crss		27.1	_	pF		
Total Gate Charge (Note 16)	Qg	_	5.4	_	nC	V <sub>GS</sub> = 4.5V	
Total Gate Charge (Note 16)	Qg	_	10.3	_	nC	V <sub>DS</sub> = 30V	
Gate-Source Charge (Note 16)	Q <sub>gs</sub>		1.7	_	nC	V <sub>GS</sub> = 10V I <sub>D</sub> = 4.5A	
Gate-Drain Charge (Note 16)	Q <sub>qd</sub>	_	3.2	_	nC		
Turn-On Delay Time (Note 16)	t <sub>D(on)</sub>		2.7		ns	$V_{DD}\text{= }30\text{V}, \text{V}_{GS}\text{= }10\text{V}$ $I_{D}\text{= }1\text{A}, \text{R}_{G}\cong 6.0\Omega$	
Turn-On Rise Time (Note 16)	tr		2.4		ns		
Turn-Off Delay Time (Note 16)	t <sub>D(off)</sub>		14.7		ns		
Turn-Off Fall Time (Note 16)	t <sub>f</sub>		5.4		ns		

14. Measured under pulsed conditions. Pulse width  $\leq$  300µs; duty cycle  $\leq$  2%. 15. For design aid only, not subject to production testing. 16. Switching characteristics are independent of operating junction temperatures. Notes:

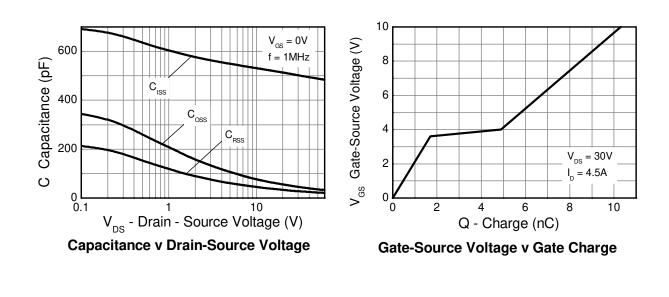


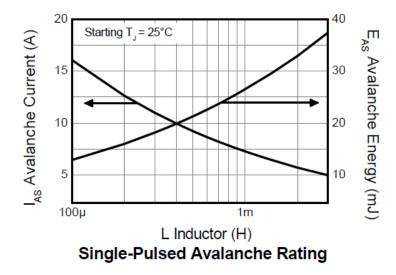
#### **Typical Characteristics**





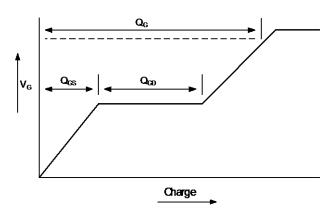
## Typical Characteristics (continued)



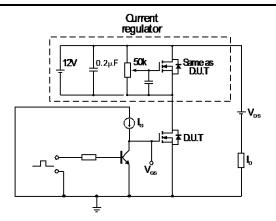




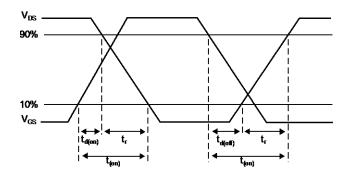




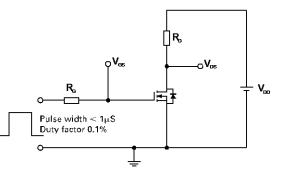
Basic gate charge waveform



Gate charge test circuit



Switching time waveforms

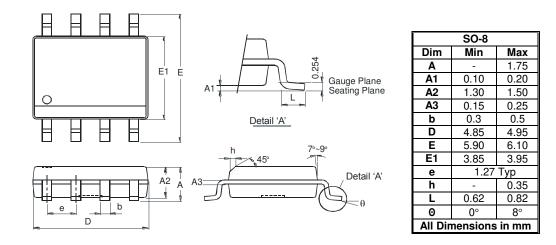


Switching time test circuit



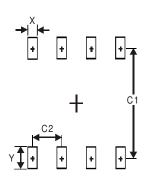
#### **Package Outline Dimensions**

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



#### Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



#### **IMPORTANT NOTICE**

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

#### LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
  - 1. are intended to implant into the body, or
  - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2015, Diodes Incorporated

www.diodes.com